ON Semiconductor

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Power MOSFET

30 V, 54 A, Single N-Channel, DPAK/IPAK

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Low RG
- These are Pb-Free Devices

Applications

- CPU Power Delivery
- DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltag	V _{DSS}	30	V		
Gate-to-Source Voltage	V _{GS}	±20	V		
Continuous Drain		T _A = 25°C	I _D	10.8	Α
Current (R _{θJA}) (Note 1)		T _A = 85°C		8.4	
Power Dissipation (R _{θJA}) (Note 1)		T _A = 25°C	P _D	2.0	W
Continuous Drain		T _A = 25°C	I _D	8.6	Α
Current ($R_{\theta JA}$) (Note 2)	Steady	T _A = 85°C		6.7	
Power Dissipation $(R_{\theta JA})$ (Note 2)	State	T _A = 25°C	P _D	1.28	W
Continuous Drain		T _C = 25°C	I _D	54	Α
Current (R ₀ JC) (Note 1)		T _C = 85°C		42	
Power Dissipation (R _{θJC}) (Note 1)		T _C = 25°C	P _D	50	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	120	Α
Current Limited by Pack	age	T _A = 25°C	I _{DmaxPkg}	45	Α
Operating Junction and	Operating Junction and Storage Temperature				
Source Current (Body Di	IS	41	Α		
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-S Energy (V_{DD} = 24 V, V_{GS} L = 0.3 mH, $I_{L(pk)}$ = 21 A	E _{AS}	66	mJ		
Lead Temperature for So (1/8" from case for 10 s)	ldering Pu	rposes	TL	260	°C

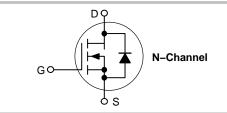
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	10 mΩ @ 10 V	54 A
55 V	16.7 mΩ @ 4.5 V	J-7.7





STYLE 2



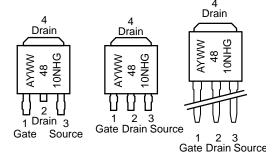


3 IPAK CASE 369AC (Straight Lead)



IPAK CASE 369D (Straight Lead DPAK) STYLE 2

MARKING DIAGRAMS & PIN ASSIGNMENTS



A = Assembly Location* Y = Year

WW = Work Week
4810NH = Device Code
G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

^{*} The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	3.0	°C/W
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	75	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	117	

- Surface–mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
 Surface–mounted on FR4 board using the minimum recommended pad size.

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				27		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		$V_{DS} = 24 \text{ V}$	T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V ₀	$_{\rm GS}$ = ± 20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$	D = 250 μA	1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 to	I _D = 30 A		8.0	10	mΩ
		11.5 V	I _D = 15 A		7.8		
	V	$V_{GS} = 4.5 \text{ V}$ $I_{D} = 30 \text{ A}$ $I_{D} = 15 \text{ A}$		14.1	16.7	1	
			I _D = 15 A		13.2		7
Forward Transconductance	gFS	V _{DS} = 15 V, I _D = 10 A			9.0		S
CHARGES AND CAPACITANCES						•	•
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 12 \text{ V}$			1225		pF
Output Capacitance	C _{oss}				280		
Reverse Transfer Capacitance	C _{rss}	*D3 –			145		
Total Gate Charge	$Q_{G(TOT)}$				8.9	12	nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 V,$	V _{DS} = 15 V,		2.5		
Gate-to-Source Charge	Q_{GS}	$I_D = 3$	30 A		3.6		
Gate-to-Drain Charge	Q_{GD}				3.9		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 11.5 \text{ V},$ $I_{D} = 3$			22.5		nC
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t _{d(on)}				10.6		ns
Rise Time	t _r	$V_{GS} = 4.5 V,$	V _{DS} = 15 V,		19.2		
Turn-Off Delay Time	t _{d(off)}	$I_D = 15 \text{ A}, R_G = 3.0 \Omega$			11.7		
Fall Time	t _f				3.6		
Turn-On Delay Time	t _{d(on)}				6.2		ns
Rise Time	t _r	V _{GS} = 11.5 V,	V _{DS} = 15 V,		18		
Turn-Off Delay Time	t _{d(off)}	$I_D = 15 \text{ A}, R_G = 3.0 \Omega$			18.5		
Fall Time	t _f				2.2		

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
RAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 V$,	T _J = 25°C		0.88	1.2	V
		I _S = 30 A	T _J = 125°C		0.79		
Reverse Recovery Time	t _{RR}				13.4		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, dIs}/$	V _{GS} = 0 V, dls/dt = 100 A/μs,		9.1		
Discharge Time	tb	I _S = 30 A			4.3		
Reverse Recovery Time	Q_{RR}				6.7		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				2.49		nΗ
Drain Inductance, DPAK	L _D				0.0164		
Drain Inductance, IPAK	L _D	T _A = 25°C			1.88		1
Gate Inductance	L _G				3.46		
Gate Resistance	R _G	1			0.75		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width \leq 300 µs, Duty Cycle \leq 2%.

^{4.} Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

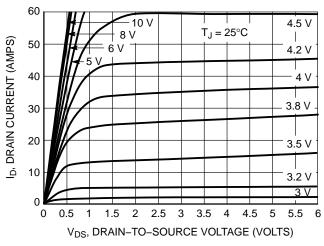


Figure 1. On-Region Characteristics

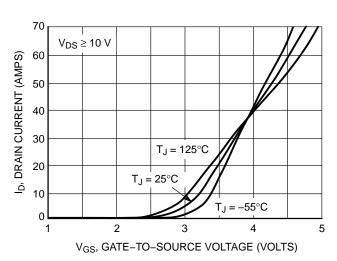


Figure 2. Transfer Characteristics

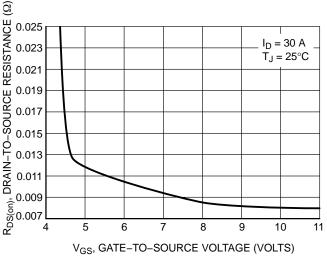


Figure 3. On–Resistance vs. Gate–to–Source Voltage

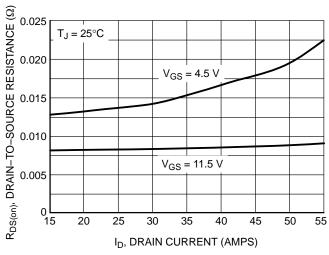


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

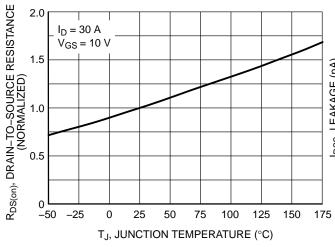


Figure 5. On–Resistance Variation with Temperature

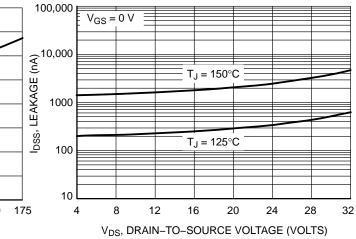
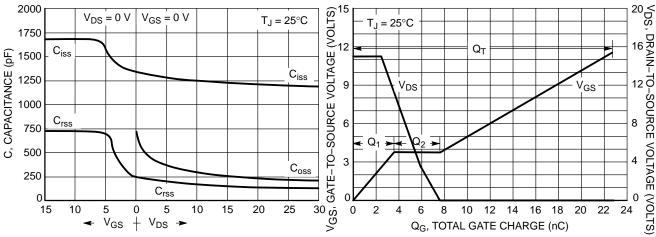


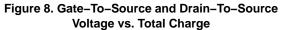
Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation



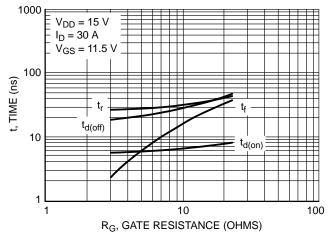


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

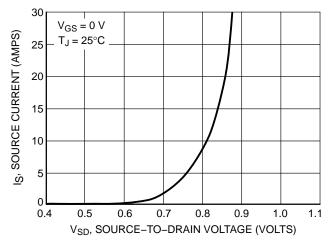


Figure 10. Diode Forward Voltage vs. Current

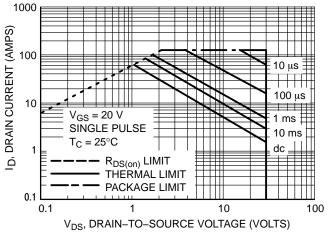


Figure 11. Maximum Rated Forward Biased Safe Operating Area

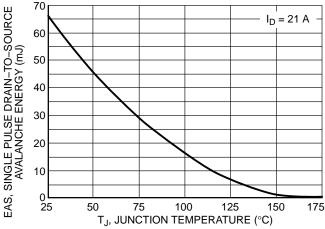


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

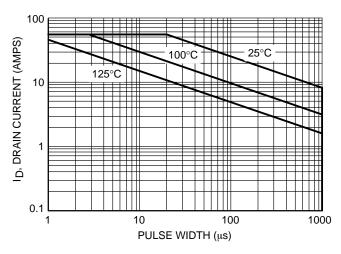


Figure 13. Avalanche Characteristics

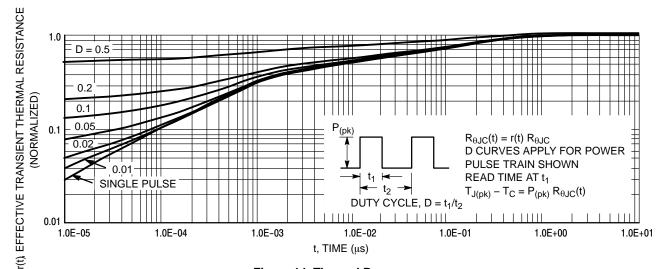


Figure 14. Thermal Response

ORDERING INFORMATION

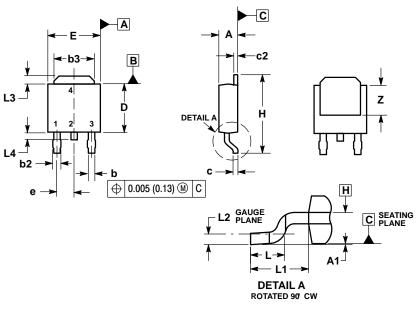
Order Number	Package	Shipping [†]
NTD4810NHT4G	DPAK (Pb-Free)	2500 Tape & Reel
NTD4810NH-1G	IPAK (Pb-Free)	75 Units/Rail
NTD4810NH-35G	IPAK Trimmed Lead (3.5 ± 0.15 mm) (Pb-Free)	75 Units/Rail

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE)

CASE 369AA **ISSUE B**



NOTES:

- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

 2. CONTROLLING DIMENSION: INCHES.

 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.

 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.

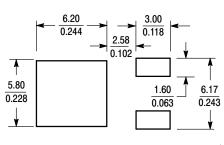
 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

 6. DATUMS A AND B ARE DETERMINED AT DATUM
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INC	HES	MILLIM	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29	BSC	
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108	REF	2.74 REF		
L2	0.020	BSC	0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

SOLDERING FOOTPRINT*

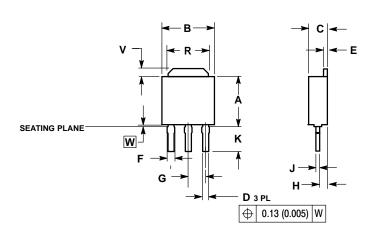


 $\left(\frac{\text{mm}}{\text{inches}}\right)$ SCALE 3:1

^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

3 IPAK, STRAIGHT LEAD CASE 369AC **ISSUE O**

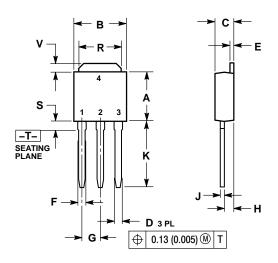


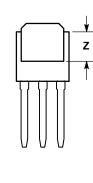
- 1.. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2.. CONTROLLING DIMENSION: INCH. 3. SEATING PLANE IS ON TOP OF

- DAMBAR POSITION.
 DIMENSION A DOES NOT INCLUDE DAMBAR POSITION OR MOLD GATE.

	INC	HES	MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.043	0.94	1.09
G	0.090 BSC		2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.134	0.142	3.40	3.60
R	0.180	0.215	4.57	5.46
V	0.035	0.050	0.89	1.27
W	0.000	0.010	0.000	0.25

IPAK CASE 369D **ISSUE C**





NOTES

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	0.090 BSC		BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2:

- PIN 1. GATE 2. DRAIN

 - 3. SOURCE DRAIN

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